

L Number	Hits	Search Text	DB	Time stamp
1	337273	mask or photomask or reticle	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:50
2	711510	euv or (enhanced ajd ultraviolet)	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:50
3	734385	reflect or reflection or reflective or reflected	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:50
4	734385	reflect or reflection or reflective or reflected	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:50
5	399426	defect or defective	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:51
6	201328	repair or repaired or repairing	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:51
7	12777	(mask or photomask or reticle ) same (defect or defective )	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:51
8	2051	(mask or photomask or reticle ) same (repair or repaired or repairing )	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:52
9	907	(reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (defect or defective ))	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:52
10	124	(reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (repair or repaired or repairing ))	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:52
11	124	((euv or (enhanced ajd ultraviolet) ) same ((reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (defect or defective )))	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:52
12	52	((euv or (enhanced ajd ultraviolet) ) same ((reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (repair or repaired or repairing )))	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:53
13	30183	((defect or defective ) or (repair or repaired or repairing )).clm.	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:53
14	56	((reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (repair or repaired or repairing ))) and (((defect or defective ) or (repair or repaired or repairing )).clm.)	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:54
15	50	((euv or (enhanced ajd ultraviolet) ) same ((reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (defect or defective )))) and (((defect or defective ) or (repair or repaired or repairing )).clm.)	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:54
16	88	((reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (repair or repaired or repairing ))) and (((defect or defective ) or (repair or repaired or repairing )).clm.) or ((euv or (enhanced ajd ultraviolet) ) same ((reflect or reflection or reflective or reflected ) same ((mask or photomask or reticle ) same (defect or defective )))) and (((defect or defective ) or (repair or repaired or repairing )).clm.))	USPAT; US-PGPUB; EPO; JPO	2004/07/08 08:54